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Kind regards,

Team Nexperia



PBSS2540E

40 V, 500 mA NPN low V_{CEsat} (BISS) transistor Rev. 02 — 15 November 2009

Product data sheet

Product profile

1.1 General description

NPN low V_{CEsat} Breakthrough in Small Signal (BISS) transistor in a SOT416 (SC-75) SMD plastic package.

PNP complement: PBS3540E.

1.2 Features

- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability: I_C and I_{CM}
- High collector current gain (h_{FE}) at high I_C
- High efficiency due to less heat generation
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

1.3 Applications

- DC-to-DC conversion
- MOSFET gate driving
- Motor control
- Charging circuits
- Low power switches (e.g. motors, fans)

1.4 Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--------------------|---|--|--------------|-----|-----|------|
| V_{CEO} | collector-emitter voltage | open base | - | - | 40 | V |
| I _C | collector current (DC) | | - | - | 500 | mA |
| I _{CM} | peak collector current | | - | - | 1 | Α |
| R _{CEsat} | collector-emitter saturation resistance | $I_C = 500 \text{ mA};$ $I_B = 50 \text{ mA}$ | <u>[1]</u> - | 380 | 500 | mΩ |

[1] Pulse test: $t_p \le 300 \ \mu s; \ \delta \le 0.02$



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40 V, 500 mA NPN low V_{CEsat} (BISS) transistor

Pinning information 2.

Table 2. **Pinning**

| Pin | Description | Simplified outline Symbol |
|-----|-------------|---------------------------|
| 1 | base | F10 |
| 2 | emitter | 3 |
| 3 | collector | 1 1 2 |
| | | sym021 |

3. **Ordering information**

Ordering information Table 3.

| Type number | Package | | |
|-------------|---------|--|---------|
| | Name | Description | Version |
| PBSS2540E | SC-75 | plastic surface mounted package; 3 leads | SOT416 |

Marking 4.

Table 4. **Marking codes**

| Type number | Marking code |
|-------------|--------------|
| PBSS2540E | 1S |

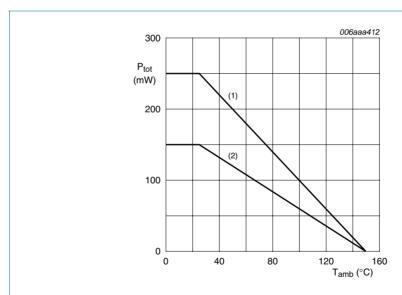
5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|------------------|---------------------------|-----------------------------|-------|------|------|
| V_{CBO} | collector-base voltage | open emitter | - | 40 | V |
| V_{CEO} | collector-emitter voltage | open base | - | 40 | V |
| V_{EBO} | emitter-base voltage | open collector | - | 6 | V |
| I _C | collector current (DC) | | - | 500 | mA |
| I _{CM} | peak collector current | | - | 1 | Α |
| I_{BM} | peak base current | | - | 100 | mA |
| P _{tot} | total power dissipation | $T_{amb} \le 25 ^{\circ}C$ | [1] - | 150 | mW |
| | | | [2] _ | 250 | mW |
| T _j | junction temperature | | - | 150 | °C |
| T _{amb} | ambient temperature | | -65 | +150 | °C |
| T _{stg} | storage temperature | | -65 | +150 | °C |
| | | | | | |

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1cm².



- (1) FR4 PCB, mounting pad for collector 1cm²
- (2) FR4 PCB, standard footprint

Fig 1. Power derating curves



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40 V, 500 mA NPN low V_{CEsat} (BISS) transistor

Thermal characteristics 6.

Table 6. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--|-------------------------|-------------|--------------|-----|-----|------|
| R _{th(j-a)} thermal resistance from junction to ambient | thermal resistance from | in free air | [1] - | - | 833 | K/W |
| | junction to ambient | | <u>[2]</u> _ | - | 500 | K/W |

- Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1cm².

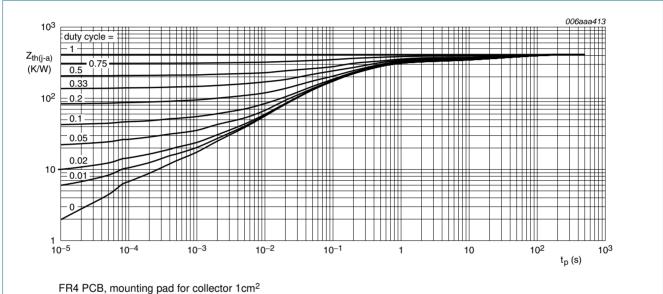


Fig 2. Transient thermal impedance from junction to ambient as a function of pulse time; typical values

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40 V, 500 mA NPN low V_{CEsat} (BISS) transistor

Characteristics

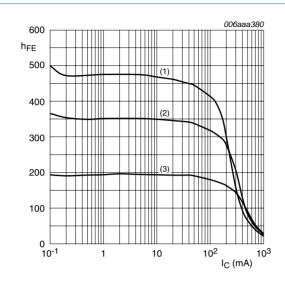
Table 7. Characteristics

T_{amb} = 25 °C unless otherwise specified

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--------------------|---|---|--------------|-----|-----|------|
| I _{CBO} | collector-base cut-off | $V_{CB} = 30 \text{ V}; I_E = 0 \text{ A}$ | - | - | 100 | nA |
| | current | $V_{CB} = 30 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 \text{ °C}$ | - | - | 50 | μА |
| I _{EBO} | emitter-base cut-off current | $V_{EB} = 5 \text{ V}; I_{C} = 0 \text{ A}$ | - | - | 100 | nA |
| h _{FE} | DC current gain | $V_{CE} = 2 \text{ V}; I_{C} = 10 \text{ mA}$ | 200 | - | - | |
| | | $V_{CE} = 2 \text{ V}; I_{C} = 100 \text{ mA}$ | 100 | - | - | |
| | | $V_{CE} = 2 \text{ V}; I_{C} = 500 \text{ mA}$ | <u>11</u> 50 | - | - | |
| V _{CEsat} | collector-emitter saturation voltage | $I_C = 10 \text{ mA}; I_B = 0.5 \text{ mA}$ | - | - | 50 | mV |
| | | $I_C = 100 \text{ mA}; I_B = 5 \text{ mA}$ | - | - | 100 | mV |
| | | $I_C = 200 \text{ mA}; I_B = 10 \text{ mA}$ | - | - | 200 | mV |
| | | $I_C = 500 \text{ mA}; I_B = 50 \text{ mA}$ | <u>[1]</u> - | - | 250 | mV |
| R _{CEsat} | collector-emitter saturation resistance | $I_C = 500 \text{ mA}; I_B = 50 \text{ mA}$ | [1] - | 380 | 500 | mΩ |
| V_{BEsat} | base-emitter saturation voltage | $I_C = 500 \text{ mA}; I_B = 50 \text{ mA}$ | [1] - | - | 1.2 | V |
| V_{BEon} | base-emitter turn-on voltage | $V_{CE} = 2 \text{ V}; I_{C} = 100 \text{ mA}$ | - | - | 1.1 | V |
| f _T | transition frequency | $V_{CE} = 5 \text{ V}; I_{C} = 100 \text{ mA};$ f = 100 MHz | 250 | 450 | - | MHz |
| C _c | collector capacitance | $V_{CB} = 10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz | - | - | 6 | pF |

^[1] Pulse test: $t_p \le 300 \ \mu s; \ \delta \le 0.02$

40 V, 500 mA NPN low V_{CEsat} (BISS) transistor



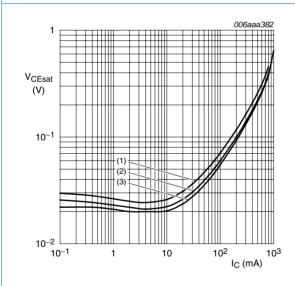
$$V_{CE} = 2 V$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = -55 \,^{\circ}C$$

Fig 3. DC current gain as a function of collector current; typical values



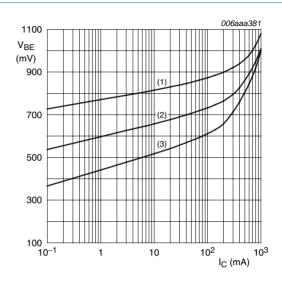
$$I_{\rm C}/I_{\rm B} = 20$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 5. Collector-emitter saturation voltage as a function of collector current; typical values



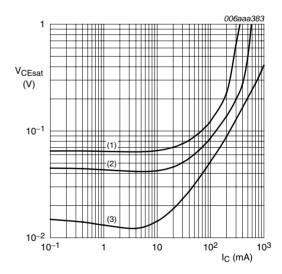
$$V_{CE} = 2 V$$

(1)
$$T_{amb} = -55 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = 100 \, ^{\circ}C$$

Fig 4. Base-emitter voltage as a function of collector current; typical values



$$T_{amb} = 25 \, ^{\circ}C$$

(1)
$$I_C/I_B = 100$$

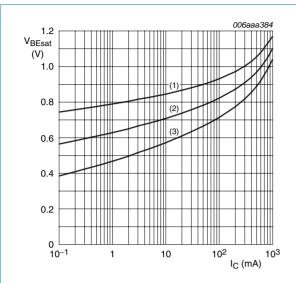
(2)
$$I_C/I_B = 50$$

(3)
$$I_C/I_B = 10$$

Fig 6. Collector-emitter saturation voltage as a function of collector current; typical values

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40 V, 500 mA NPN low V_{CEsat} (BISS) transistor



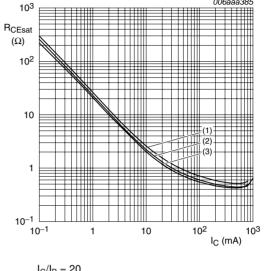
$$I_{\rm C}/I_{\rm B} = 20$$

(1)
$$T_{amb} = -55 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = 100 \, ^{\circ}C$$

Fig 7. Base-emitter saturation voltage as a function of collector current; typical values



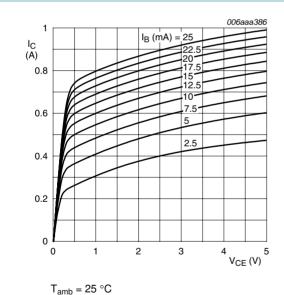
$$I_C/I_B = 20$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

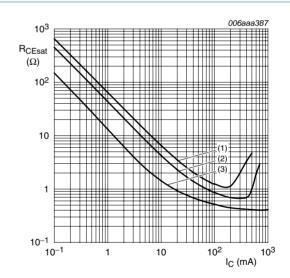
(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 8. Collector-emitter saturation resistance as a function of collector current; typical values



Collector current as a function of Fig 9. collector-emitter voltage; typical values



$$T_{amb} = 25 \, ^{\circ}C$$

(1)
$$I_C/I_B = 100$$

(2)
$$I_C/I_B = 50$$

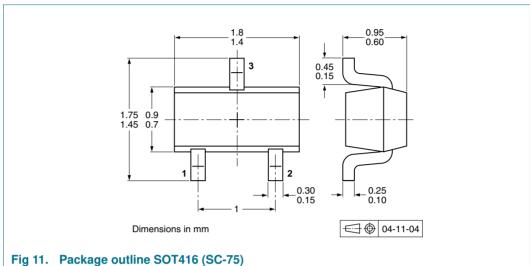
(3)
$$I_C/I_B = 10$$

Fig 10. Collector-emitter saturation resistance as a function of collector current; typical values

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Package outline 8.



Packing information

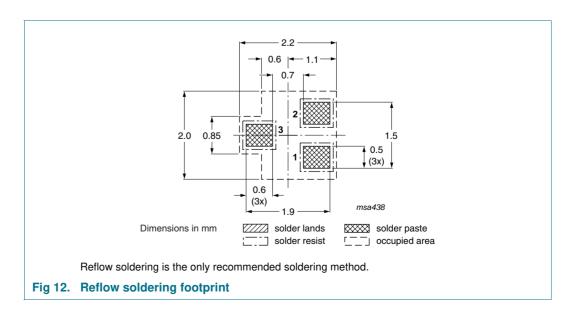
Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

| Type number | Package | Description | Packing quantity | |
|-------------|---------|--------------------------------|------------------|-------|
| | | | 3000 | 10000 |
| PBSS2540E | SOT416 | 4 mm pitch, 8 mm tape and reel | -115 | -135 |

^[1] For further information and the availability of packing methods, see Section 13.

10. Soldering



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11. Revision history

Table 9. **Revision history**

| | • | | | | | |
|----------------|---|---|---------------|----------------------------|--|--|
| Document ID | Release date | Data sheet status | Change notice | Supersedes | | |
| PBSS2540E_2 | 20091115 | Product data sheet | - | PBSS2540E_1 | | |
| Modifications: | This data sheet was changed to reflect the new company name NXP Semiconductors, including new legal definitions and disclaimers. No changes were made to the technical content. | | | | | |
| | | ollector-emitter saturation versat unit amended from mV | | collector current; typical | | |
| | | ollector-emitter saturation versat unit amended from mV | | collector current; typical | | |
| | Figure 12 "F | Reflow soldering footprint": | updated | | | |
| PBSS2540E_1 | 20050504 | Product data sheet | - | - | | |
| | | | | | | |

NXP Semiconductors PBSS2540E

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| Document status[1][2] | Product status[3] | Definition |
|--------------------------------|-------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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NXP Semiconductors

PBSS2540E

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